

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/813,342	SATOH, TOMIO	
Examiner	Art Unit	
Joseph Chang	2817	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST(attached)	6/20/2005	JC	
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